

<b>Notice of References Cited</b>	Application/Control No. 10/070,213	Applicant(s)/Patent Under Reexamination KUIPERS ET AL.	
	Examiner Maribel Medina	Art Unit 1754	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,942,346	08-1999	Ahmed et al.	429/20
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Michalski et al., Temperature Measurement, 2nd Edition, John Wiley & Sons Ltd, pp. 209-228, 2001.
	V	Perry et al., Perry's Chemical Engineer's Handbook, 7th Edition McGraw-Hill, pp. 8-65 to 8-84, 1997.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.